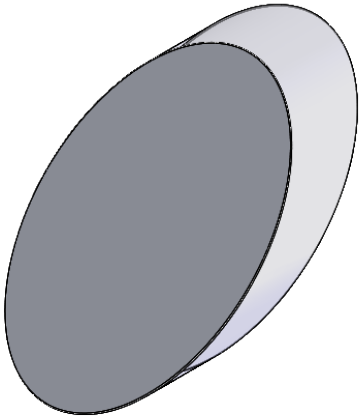
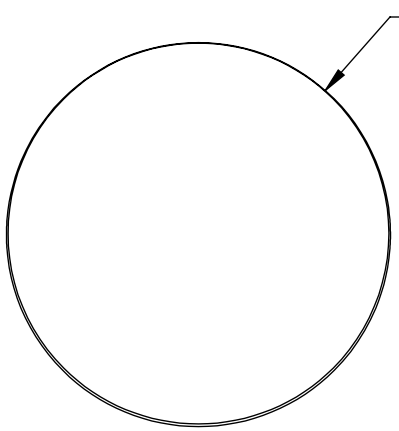
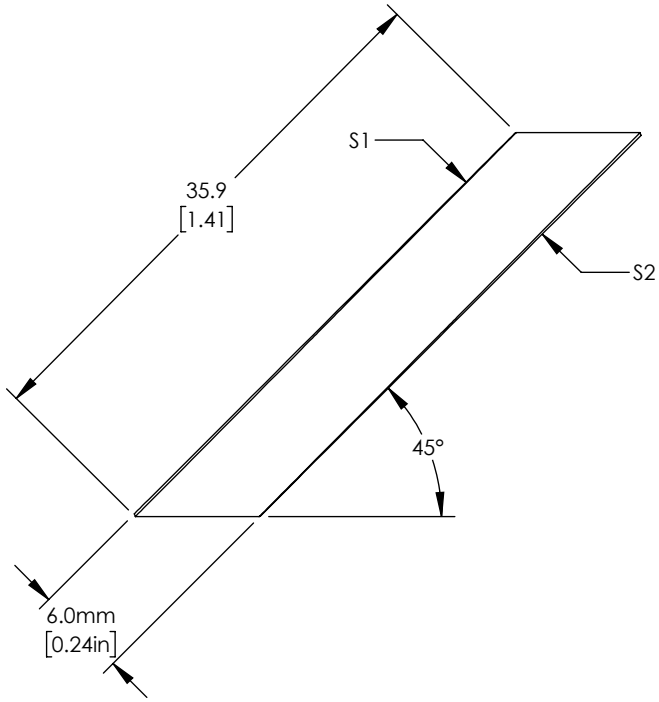
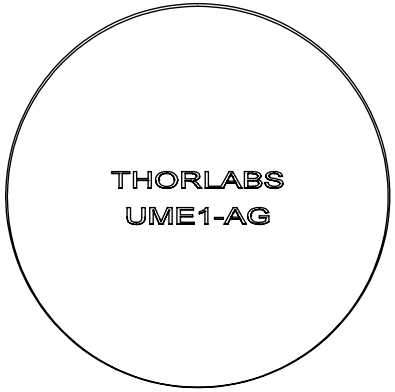








NOTES/SPECIFICATIONS:

1. CLEAR APERTURE: > Ø22.9mm
2. SURFACE QUALITY (S1): 40-20 SCRATCH-DIG
3. SURFACE FLATNESS (S1): λ/10 AT 633nm
   (S2): FINE GROUND
4. THICKNESS TOLERANCE: ±0.2mm
5. DIAMETER TOLERANCE: +0.0/-0.1mm
6. PARALLELISM: <5arcmin
7. COATING: ENHANCED AG COATING
   WAVELENGTH RANGE: 750 nm - 1000 nm
   AOI: 45°
   S-POLARIZATION: R > 99.0%, |GDD| < 20 fs²
   P-POLARIZATION: R > 98.5%, |GDD| < 30 fs²

FOR INFORMATION ONLY
NOT FOR MANUFACTURING PURPOSES

DRAWING PROJECTION		
	NAME	DATE
DRAWN	CAL	04/SEP/20
APPROVAL	MG	04/SEP/20

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VALUES IN PARENTHESIS ARE CALCULATED AND MAY CONTAIN ROUNDOFF ERRORS

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MATERIAL	REV
FUSED SILICA	A

ITEM #	APPROX WEIGHT
UME1-AG	9 g